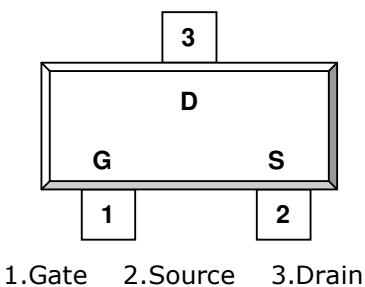


### DESCRIPTION

HM2318B is the N-Channel logic enhancement mode power field effect transistor is produced using high cell density, DMOS trench technology. This high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage application such as cellular phone and notebook computer power management, other battery powered circuits, and low in-line power loss are needed in a very small outline surface mount package.

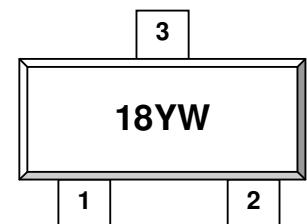
### PIN CONFIGURATION

SOT-23



### PART MARKING

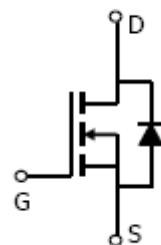
SOT-23



Y: Year Code    W: Week Code

### FEATURE

- 40V/3.9A,  $R_{DS(ON)} = 42\text{m}\Omega$  (Typ.)  
@VGS = 10V
- 40V/3.5A,  $R_{DS(ON)} = 53\text{m}\Omega$   
@VGS = 4.5V
- 40V/2.0A,  $R_{DS(ON)} = 75\text{ m}\Omega$   
@VGS = 2.5V
- Super high density cell design for extremely low  $R_{DS(ON)}$
- Exceptional on-resistance and maximum DC current capability
- SOT-23 package design



**ABSOLUTE MAXIMUM RATINGS** ( $T_a = 25^\circ C$  Unless otherwise noted )

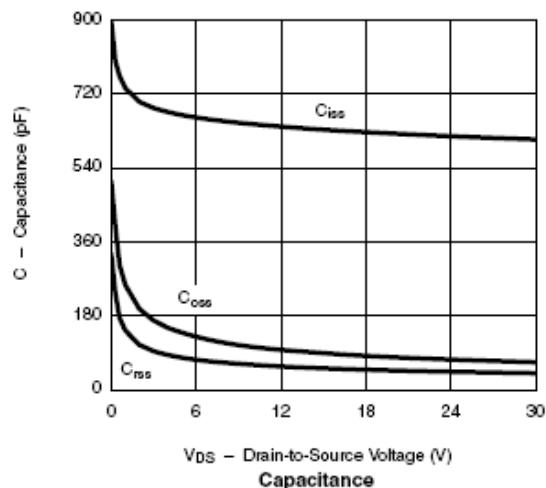
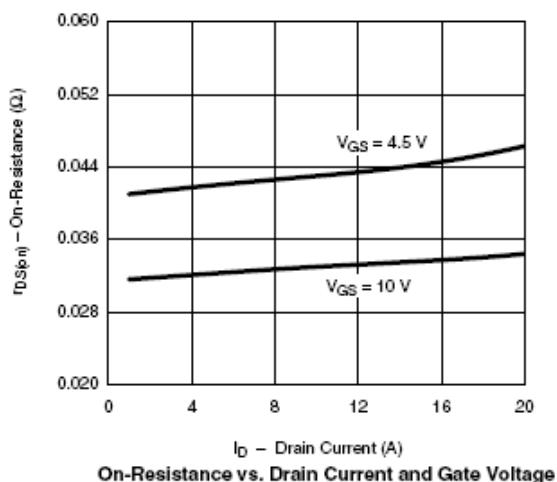
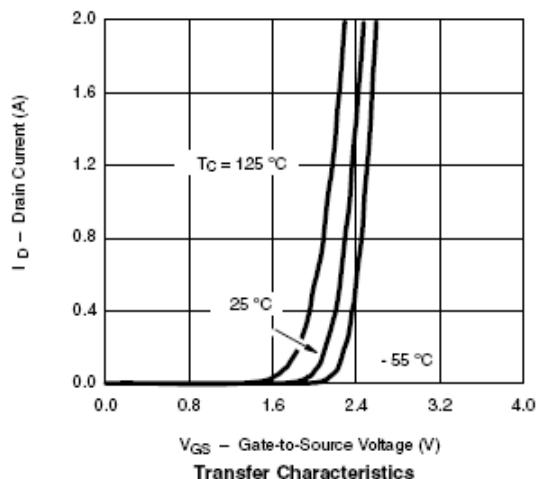
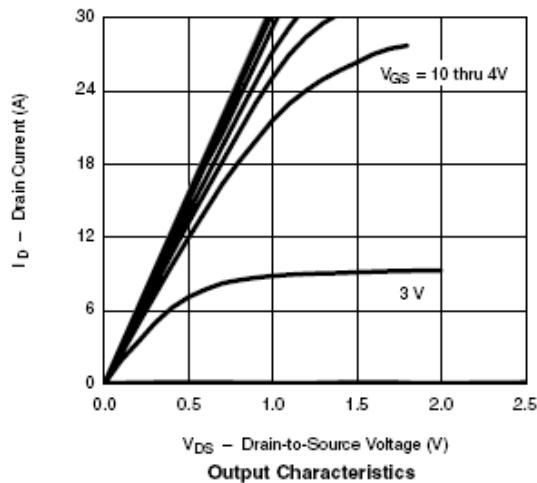
Parameter	Symbol	Typical	Unit
Drain-Source Voltage	$V_{DSS}$	40	V
Gate-Source Voltage	$V_{GSS}$	$\pm 20$	V
Continuous Drain Current ( $T_J = 150^\circ C$ )	$I_D$	3.9 3.0	A
Pulsed Drain Current	$I_{DM}$	10	A
Continuous Source Current (Diode Conduction)	$I_S$	1.20	A
Power Dissipation	$P_D$	1.20 0.8	W
Operation Junction Temperature	$T_J$	150	$^\circ C$
Storage Temperature Range	$T_{STG}$	-55/150	$^\circ C$
Thermal Resistance-Junction to Ambient	$R_{\theta JA}$	100	$^\circ C/W$

**ELECTRICAL CHARACTERISTICS ( Ta = 25°C Unless otherwise noted )**

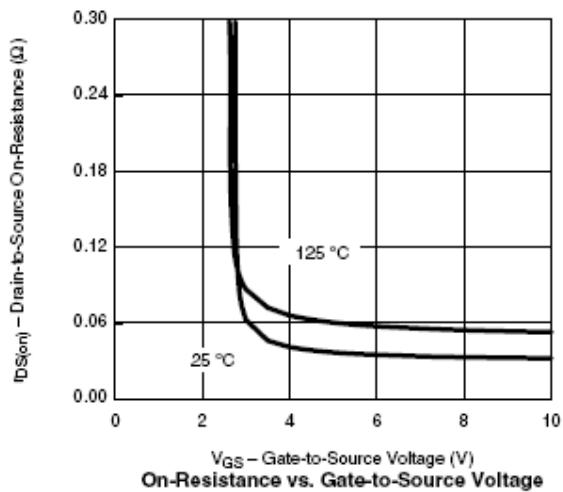
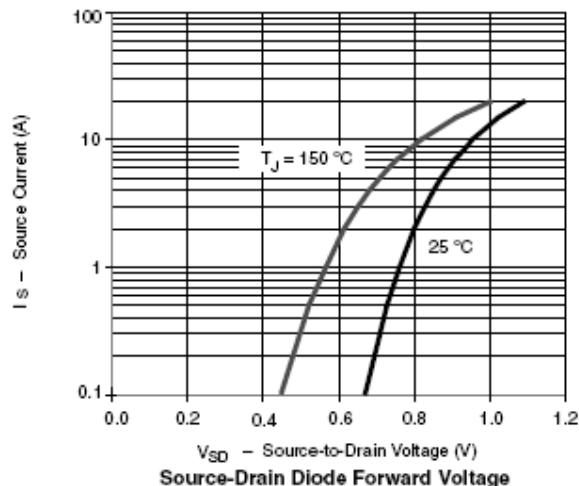
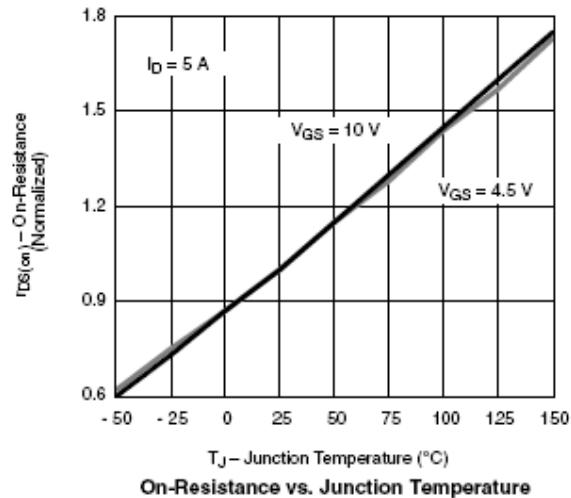
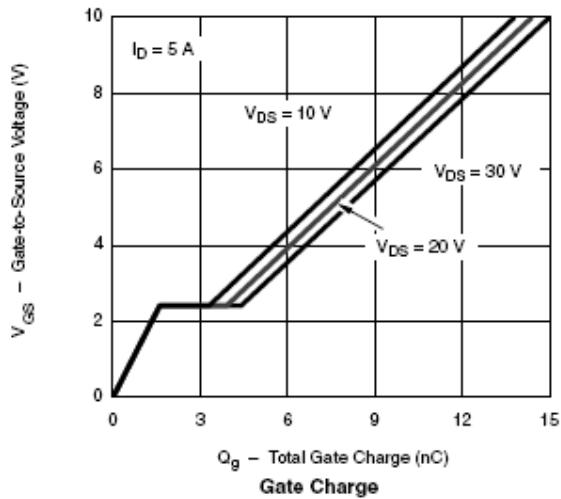
Parameter	Symbol	Condition	Min	Typ	Max	Unit	
<b>Static</b>							
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=250\mu A$	40			V	
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	0.50		1.2	V	
Gate Leakage Current	$I_{GSS}$	$V_{DS}=0V, V_{GS}=\pm 20V$			$\pm 100$	nA	
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=40V, V_{GS}=0V$			1	uA	
		$V_{DS}=40V, V_{GS}=0V$ $T_J=85^\circ C$			5		
Drain-source On-Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=3.9A$ $V_{GS}=4.5V, I_D=3.5A$ $V_{GS}=2.5V, I_D=2.0A$		0.042 0.053 0.075		$\Omega$	
Forward Transconductance	$g_{fs}$	$V_{DS}=15V, I_D=6.2A$		13		S	
Diode Forward Voltage	$V_{SD}$	$I_S=2.3A, V_{GS}=0V$		0.8	1.2	V	
<b>Dynamic</b>							
Total Gate Charge	$Q_g$	$V_{DS}=15V$ $V_{GS}=10V$ $I_D \equiv 2.0A$		16	24	nC	
Gate-Source Charge	$Q_{gs}$			3			
Gate-Drain Charge	$Q_{gd}$			2.5			
Turn-On Time	$t_{d(on)}$ $t_r$	$V_{DD}=15V$ $R_L=15\Omega$ $I_D=1.0A$ $V_{GEN}=10V$ $R_G=6\Omega$		15	20	nS	
Turn-Off Time	$t_{d(off)}$ $t_f$			6	12		
				10	20		
				40	80		



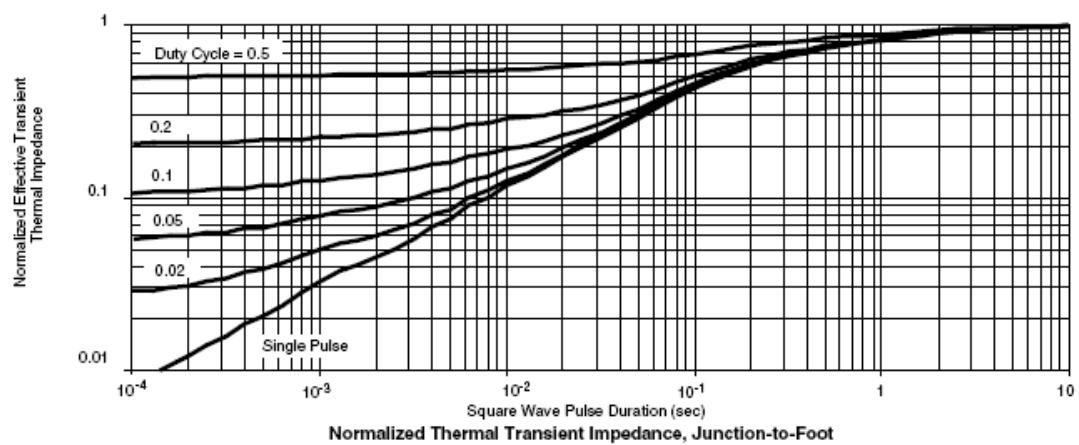
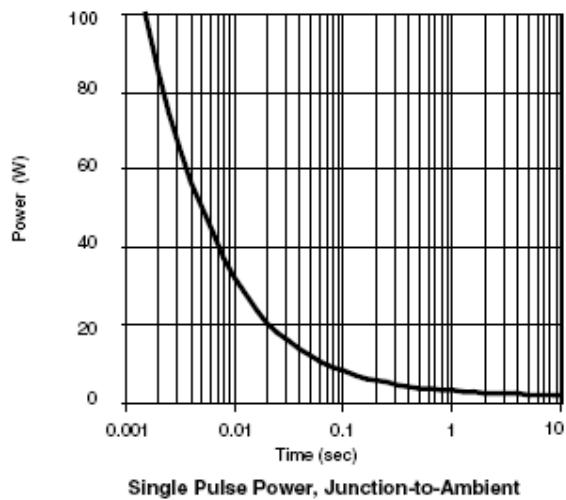
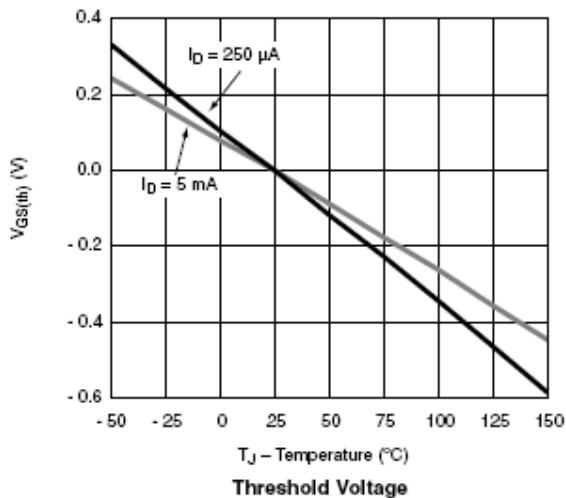
**TYPICAL CHARACTERISTICS** (25°C Unless noted)



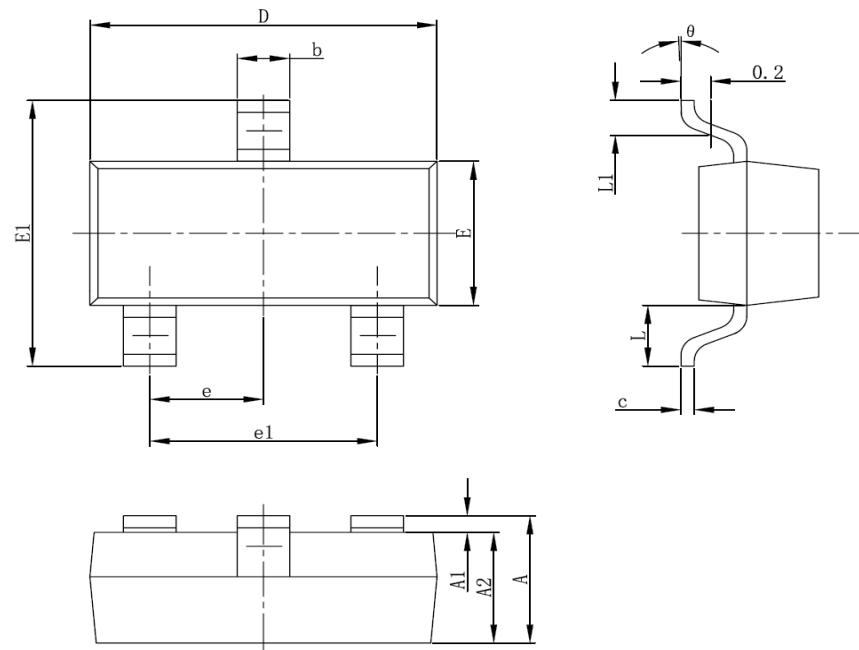
**TYPICAL CHARACTERISTICS** (25°C Unless noted)



**TYPICAL CHARACTERISTICS** (25°C Unless noted)



**SOT-23 PACKAGE OUTLINE**



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	0.900	1.100	0.035	0.043
A1	0.000	0.100	0.000	0.004
A2	0.900	1.000	0.035	0.039
b	0.300	0.500	0.012	0.020
c	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
e	0.950TYP		0.037TYP	
e1	1.800	2.000	0.071	0.079
L	0.550REF		0.022REF	
L1	0.300	0.500	0.012	0.020
$\theta$	0°	8°	0°	8°